Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/532,155	VANDERPERREN ET AL.	VANDERPERREN ET AL.	
Examiner	Art Unit	Art Unit	
NAHEED EJAZ	2611	2611	

	SEARCHED				
Class	Subclass	Date	Examiner		
375	130,139, 147,150, 316,322	3/28/2008	NE		
375	324	3/28/2008	NE		
375	335,340	3/28/2008	NE		
375	343	3/28/2008	NE		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
375	326	3/28/2008	NE	
375/130,139,147,150, 316,322,324,335,340, 343		3/28/2008	NE	

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
EAST search attached	3/28/2008	NE
Inventorship	3/28/2008	NE
Consulted with SPE Chieh M. Fan	3/28/2008	NE